## terotest

The TR5001T Tiny 2 ICT is a full feature In-Circuit board tester with a laptop sized footprint that provides a very cost effective alternative to large In-Circuit testers.

TINY 2 ICT can be fitted with up to 640 relay switched (six wire) Analogue Test points plus 16 bidirectional Digital pins.

PXI or GPIB instruments may be added to provide a full functional Test capability.

TINY 2 ICT is small enough to mount in your PXI test rack.

- TestJet Technology
- R/L/C Measurement
- Capacitor Polarity Test
- Transistor/Diode Measurement
- Voltage Measurement
- Sine Wave Generator
- Frequency Measurement
- 100V High Voltage Current Source
- On Board Serial Flash Programming
- Supports External Instrumentation
- Self Calibration and Diagnostics

Can be supplied as a standalone unit or fully integrated, including systems interface receiver within an 'iTest' frame.

# TINY 2 IN-CIRCUIT TEST SYSTEM

TR5001T



Compact, Lightweight & Powerful ICT

**Boundary Scan** 

Parallel Testing Configuration

Serial Device Programming



If you thought you couldn't test it......talk to us!

Tel: +44 (0) 1462 742499 Email: info@terotest.com W W W . t e r o t e s t . c o m

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## **TINY 2 IN-CIRCUIT TEST SYSTEM**

## General

Maximum Analogue Test Points: 640

Windows Compatible PC or Laptop with USB Ports Microsoft Windows 7 Operation System:

**Power Requirement:** 100-240V single phase, 50/60Hz, 300VA.

**Fixture Type:** Press or Manual

## **Analog Hardware**

Measurement Switching Matrix 6-wire measurement

**Programmable Frequency:** 100Hz, 1KHz, 10KHz, 100KHz Programmable DC Voltage Source:± 10V maximum, resolution: 10mV

**Programmable DC Current Source:** 100mA maximum

Programmable AC Voltage Source: 10Vpp maximum, resolution: 10mV

## **Component Measurement Capability**

40mohm - 40Mohm Resistance: 10pF - 40mF 10µH - 60H Capacitance: Inductance:

### **Analog Measurement**

AC Voltmeter: 0 - 100Vpp DC Voltmeter: 0 - ±100V, r

0 - ±100V, resolution: 2.5mV - 50mV DC Ampmeter: 1μA - 100mA, resolution: 30nA - 30μA

Optional Hardware
Dual-Stage Press Unit or Inline Handler
TestJet Technology:

Vectorless open circuit detection

Programmable High Voltage DC Source: Up to 100V/100mA Sine Wave Generator Frequency range: 1-100KHz, resolution:1Hz

Frequency Measurement: Up to 200MHz

## Serial Test Module (STM)

Two channels for serial Testing up to 1MHz with 16 channels of General Purpose Digital I/O Boundary Scan Nail connection Test(PISO/SIPO), Toggle Scan, SPII2C and UART Programmable Voltage Level: Vih: 0.8V - 4.6V at lo=20 mA; Voh:0.1V - 4.9V

## **Data Acquisition**

Two Channels, 16bits 10 MSPS flexible arbitrary / DDS waveform generator Four Channels, 16bits 3.8MSPS waveform digitizer One Channel frequency generator

## **Audio Analyzer**

24-bit audio analyzer with SNR, THD and THD+N analysis

### **Digital Test Module**

Sixteen channels General Purpose Digital I/O Four programmable DUT Power Supply: 1-20V, 0.6 - 2A, 12 Watt, current measurement 100μA - 2A Two Fixed, 12V and -12V Power: 0.3A, current measurement 10mA - 300 mA

### **Dimensions and Weight**

(W) 334mm x (D) 260mm x (H) 182mm (does not include notebook and accessories) Weight: 8-11kg (does not include notebook or accessories; final weight determined by system selected)

## Powerful Software Environment

Auto debug for all passive tests (shorts/opens), R/L/C components, clamping diodes, and TestJet) Built in system diagnostics

Test Coverage and CPK reporting are standard

Board View will visually highlight failures to device/pin/trace level Board Revision software (single program for multiple board versions) Program Modification Report (Reports any changes to program after release)

Shop floor system support

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